Not Recommended for New Designs

This product was manufactured for Maxim by an outside wafer foundry using a process that is no longer available. It is not recommended for new designs. The data sheet remains available for existing users.

A Maxim replacement or an industry second-source may be available. Please see the QuickView data sheet for this part or contact technical support for assistance.

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General Description

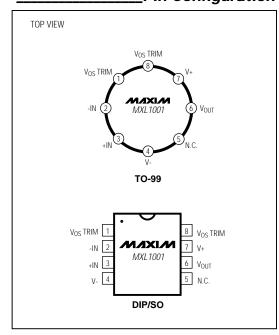
The MXL1001 offers significant specification improvement over earlier precision operational amplifiers and is pincompatible with the industry-standard LT1001. Particular attention has been paid to the optimization of key parameters such as input offset voltage, common-mode rejection, and power-supply rejection. In addition, the high-performance MXL1001C commercial temperature device provides considerable cost savings when compared to equivalent grades of competing precision amplifiers.

The input offset voltage of all units is less than $60\mu V$, allowing the premium military device, the MXL1001AM, to be specified at $15\mu V$ max. Power dissipation is close to half that of the industry-standard OP-07 precision op amp, without sacrificing noise or speed performance. A useful by-product of lower dissipation is decreased warm-up drift.

_Applications

Thermocouple Amplifiers
Low-Level Signal Processing
Strain Gauge Amplifiers
High-Accuracy Data Acquisition

Pin Configuration



Features

 Guaranteed Low Offset Voltage MXL1001AM: 15μV max MXL1001C: 60μV max

♦ Guaranteed Low Drift

MXL1001AM: $0.6\mu V/^{\circ}C$ max MXL1001C: $1.0\mu V/^{\circ}C$ max

♦ Guaranteed Low Bias Current MXL1001AM: 2nA max MXL1001C: 4nA max

♦ Guaranteed CMRR

MXL1001AM: 114dB min MXL1001C: 110dB min

♦ Guaranteed PSRR

MXL1001AM: 110dB min MXL1001C: 106dB min

♦ Low Power Dissipation

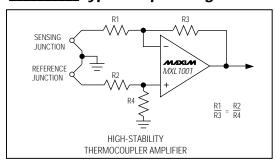
MXL1001AM: 75mW max MXL1001C: 80mW max

♦ Low Noise: 0.3μV_{p-p}

Ordering Information

PART	TEMP. RANGE	PIN-PACKAGE
MXL1001ACN8	0°C to +70°C	8 Plastic DIP
MXL1001CN8	0°C to +70°C	8 Plastic DIP
MXL1001ACS8	0°C to +70°C	8 SO
MXL1001CS8	0°C to +70°C	8 SO
MXL1001ACJ8	0°C to +70°C	8 CERDIP
MXL1001CJ8	0°C to +70°C	8 CERDIP
MXL1001ACH	0°C to +70°C	8 TO-99
MXL1001CH	0°C to +70°C	8 TO-99
MXL1001AMJ8	-55°C to +125°C	8 CERDIP
MXL1001MJ8	-55°C to +125°C	8 CERDIP
MXL1001AMH	-55°C to +125°C	8 TO-99
MXL1001MH	-55°C to +125°C	8 TO-99

Typical Operating Circuit



Maxim Integrated Products 1

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ABSOLUTE MAXIMUM RATINGS

Total Supply Voltage (V+ to V-)±22V	Duration of
Continuous Power Dissipation500mW	Operating ¹
TO-99(H)—derate at 7.1mW/°C above +80°C	MXL100
CERDIP(J)—derate at 6.7mW/°C above +75°C	MXL100
Plastic DIP(P)—derate at 5.6mW/°C above +36°C	Junction Te
Small Outline(S)—derate at 5mW/°C above +55°C	Storage Te
Differential Input Voltage±30V	Lead Temp
Input Voltage (Note 1) +22V	

Duration of Output Short Circu	itIndefinite
Operating Temperature Range	es:
MXL1001C_/AC	0°C to +70°C
MXL1001M_/AM	55°C to +125°C
Junction Temperature (T ₁)	65°C to +160°C
Storage Temperature Range	65°C to +150°C
Lead Temperature (soldering,	10sec)+300°C

Note 1: For supply voltages less than $\pm 22V$, the absolute maximum input voltage is equal to the supply voltage.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

($V_S = \pm 15V$, $T_A = +25$ °C, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS		MXL1001AM MXL1001AC			MXL1001M MXL1001C			UNITS	
			MIN	TYP	MAX	MIN	TYP	MAX			
Input Offset Voltage	Vos	(Note 2)	MXL1001AM		7	15		18	60	μV	
Input Onset Voltage	VUS	(Note 2)	MXL1001AC		10	25		18	60	μν	
Long-Term Input Offset Voltage Stability	V _{OS} /Time	(Note 3)			0.2	1.0		0.3	1.5	μV/ Month	
Input Offset Current	los				0.3	2.0		0.4	3.8	nA	
Input Bias Current	lΒ				±0.5	±2.0		±0.7	±4.0	nA	
Input Noise Voltage	e _{N p-p}	0.1Hz to 10Hz	(Note 4)		0.3	0.6		0.3	0.6	μV_{p-p}	
		f _O = 10Hz (Not	e 4)		10.3	18.0		10.5	18.0	,	
Input Noise Voltage Density	e _N	f _O = 100Hz (No	ote 4)		10.0	13.0		10.0	13.0	nV/√Hz	
		$f_{O} = 1000Hz$ (N	lote 4)		9.6	11.0		9.8	11.0		
Input Resistance (Differential Mode)	RIN	(Note 5)		30	100		15	80		MΩ	
Input Voltage Range	IVR			±13	±14		±13	±14		V	
Common-Mode Rejection Ratio	CMRR	$V_{CM} = \pm 13V$		114	126		110	126		dB	
Power-Supply Rejection Ratio	PSRR	$V_S = \pm 3V$ to ± 1	8V	110	123		106	123		dB	
Large-Signal Voltage Gain	Avo	$R_L \ge 2k\Omega$, $V_O =$	±12V	450	800		400	800		V/mV	
Large-Signal Voltage Gain		$R_L \ge 1k\Omega$, $V_O =$	±10V	300	500		250	500		7 V/IIIV	
Output Voltage Swing	Vo	$R_L \ge 2k\Omega$		±13.0	±14.0		±13.0	±14.0		V	
		$R_L \ge 1k\Omega$		±12.0	±13.5		±12.0	±13.5		_ v	
Slew Rate	SR	$R_L \ge 2k\Omega$ (Note	: 4)	0.1	0.25		0.1	0.25		V/µs	
Closed-Loop Bandwidth	BW	$A_{VCL} = +1V (N$	ote 4)	0.4	8.0		0.4	0.8		MHz	
Power Consumption	Pn	$V_S = \pm 15V$, no	load		46	75		48	80	mW	
1 ower consumption	- ا	$V_S = \pm 3V$, no lo	oad		4	6		4	8	11100	

Note 2: MXL1001A grade V_{OS} is measured one minute after application of power. For all other grades V_{OS} is measured approximately 0.5 seconds after application of power.

Note 3: Long-Term Input Offset Voltage Stability refers to the average trend line of Vos vs. Time over extended periods after the first 30 days of operation. Excluding the initial hour of operation, changes in Vos during the first 30 operating days are typically 2.5µV. Parameter is sample tested.

Note 4: Sample tested.

Note 5: Guaranteed by design.

ELECTRICAL CHARACTERISTICS

 $(V_S = \pm 15V, -55^{\circ}C \le T_A \le +125^{\circ}C, \text{ unless otherwise noted.})$

PARAMETER	SYMBOL	CONDITIONS	МХ	L1001	AM	M	UNITS		
			MIN	TYP	MAX	MIN	TYP	MAX	UNITS
Input Offset Voltage	Vos	(Note 6)		30	60		45	160	μV
Average Temperature Coefficient of Input Offset Voltage	TCV _{OS}			0.2	0.6		0.3	1.0	μV/°C
Input Offset Current	los			0.8	4.0		1.2	7.6	nA
Input Bias Current	IΒ			±1.0	±4.0		±1.5	±8.0	nA
Input Voltage Range	IVR		±13	±14		±13	±14		V
Common-Mode Rejection Ratio	CMRR	V _{CM} = ±13V	110	122		106	120		dB
Power-Supply Rejection Ratio	PSRR	$V_S = \pm 3V$ to $\pm 18V$	104	117		100	117		dB
Large-Signal Voltage Gain	Avo	$R_L \ge 2k\Omega$, $V_O = \pm 10V$	300	700		200	700		V/mV
Output Voltage Swing	Vo	$R_L \ge 2k\Omega$	±12.5	±13.5		±12.5	±13.5		V
Power Dissipation	PD	No load		55	90		60	100	mW

ELECTRICAL CHARACTERISTICS

(Vs = ± 15 V, 0°C \leq TA $\leq +70$ °C, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS	MXL1001AC			MXL1001C			UNITS
			MIN	TYP	MAX	MIN	TYP	MAX	UNITS
Input Offset Voltage	Vos	(Note 6)		20	60		30	110	μV
Average Temperature Coefficient of Input Offset Voltage	TCVos			0.2	0.6		0.3	1.0	μV/°C
Input Offset Current	los			0.5	3.5		0.6	5.3	nA
Input Bias Current	IΒ			±0.7	±3.5		±1.0	±5.5	nA
Input Voltage Range	IVR		±13	±14		±13	±14		V
Common-Mode Rejection Ratio	CMRR	V _{CM} = ±13V	110	124		106	123		dB
Power-Supply Rejection Ratio	PSRR	$V_S = \pm 3V$ to $\pm 18V$	106	120		103	120		dB
Large-Signal Voltage Gain	Avo	$R_L \ge 2k\Omega$, $V_O = \pm 10V$	350	750		250	750		V/mV
Output Voltage Swing	Vo	$R_L \ge 2k\Omega$	±12.5	±13.8		±12.5	±13.8		V
Power Dissipation	PD	No load		50	85		55	90	mW

Note 6: MXL1001A grade offset voltage is measured one minute after application of power. For all other grades V_{OS} is measured 0.5 seconds after power on.

Applications Information

The MXL1001 series devices are pin-compatible with the OP-07, OP-05, 725, 108A or 101A amplifiers. The MXL1001 amplifiers can be used to upgrade older designs using these devices, with or without removal of external frequency compensation or nulling components. The MXL1001 can also be used in 741, LF156 or OP-15 applications provided the nulling circuitry is removed.

The MXL1001 is specified over a wide supply voltage range from $\pm 3V$ to $\pm 18V$. Operation with lower supplies is possible down to $\pm 1.2V$ (two NiCd batteries), however, at this level the device is stable only in closed-loop gains of ± 2 and above (or inverting gain of one or higher). Unless proper care is exercised, thermocouple effects caused by temperature gradients across dissimilar metals at the input terminal connections, can exceed the inherent offset-voltage drift of the amplifier. Air currents over the device leads should be minimized, package leads should be short, and the two input leads should be as close together as possible and maintained at the same temperature.

Offset-Voltage Adjustment

The input offset voltage of the MXL1001, and its temperature drift, are minimized by zener-zap trimming at the wafer level. If further nulling of V_{OS} is required, this can be performed using a $10k\Omega$ or $20k\Omega$ potentiometer with no degradation of V_{OS} drift with temperature. Trimming to a value other than zero creates a drift of $(V_{OS}/300)\mu\text{V/°C}$; i.e., if V_{OS} is adjusted to $300\mu\text{V}$, the change in drift will be $1\mu\text{V/°C}$. The adjustment range with a $10k\Omega$ or $20k\Omega$ potentiometer is approximately $\pm 2.5\text{mV}$. If less adjustment range is needed, the sensitivity and resolution of the offset nulling can be improved by using a potentiometer of lower ohmic value in conjunction with fixed resistors.

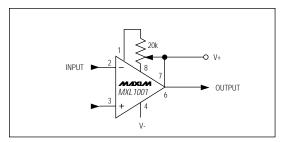
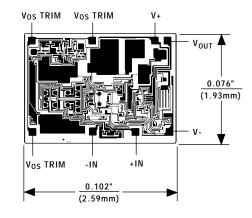


Figure 1. Optional Offset Nulling Circuit

_Chip Topography



SUBSTRATE IS CONNECTED TO V-

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